

Search Notes

Application/Control No.

10/676,109

Examiner

Brian Ensey

Applicant(s)/Patent under
Reexamination

TAKAYAMA ET AL.

Art Unit

2615

SEARCHED

Class	Subclass	Date	Examiner
Updated	search	9/12/2006	BE

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Discussed with Sinh Tran	9/12/2006	BE